

Application/Control No	. Applicant(s)/Patent under Reexamination	•
10/620,487	MAIER, THOMAS	
Examiner	Art Unit	
Lindsay Odell	1652	

SEARCHED					
Class	Subclass	Date	Examiner		
536	23.1	1/18/2005	LO		
	24.1		į		
435	320.1				
	106				
	243				
	252.3				
	252.33				
530	350	V	1		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
SEQ ID NO: 1 in DNA databases and SEQ ID NO: 2 in amino acid and DNA databases (see attached summaries)	1/3/2005	LO		
STN (see attached)	1/25/2005	LO		
WEST (see attached)	1/18/2005	LO		
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